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# **Clock Buffer/Clock Multiplier With Optional SSC**

#### **FEATURES**

- Part of a Family of Easy to use Clock Generator Devices With Optional SSC
- Clock Multiplier With Selectable Output Frequency and Selectable SSC
- SSC Controllable via 2 External Pins
   ±0%, ±0.5%, ±1%, ±2% Center Spread
- Frequency Multiplication Selectable Between x1 or x4 With One External Control Pin
- Output Disable via Control Pin
- Single 3.3V Device Power Supply
- Wide Temperature Range -40°C to 85°C
- Low Space Consumption by 8 Pin TSSOP Package

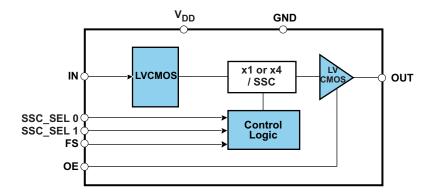
### **APPLICATIONS**

 Consumer and Industrial Applications requiring EMI reduction through Spread Spectrum Clocking and/ or Clock Multiplication

#### **PACKAGE**



#### **BLOCK DIAGRAM**



#### DESCRIPTION

The CDCS503 is a spread spectrum capable, LVCMOS Input Clock Buffer with selectable frequency multiplication.

It shares major functionality with the CDCS502 but utilizes a LVCMOS input stage instead of the crystal input stage of the CDCS502. Also an Output Enable pin has been added to the CDCS503.

The device accepts a 3.3V LVCMOS signal at the input.

The input signal is processed by a PLL, whose output frequency is either equal to the input frequency or multiplied by the factor of 4.

The PLL is also able to spread the clock signal by ±0%, ±0.5%, ±1% or ±2% centered around the output clock frequency with a triangular modulation.

By this, the device can generate output frequencies between 8MHz and 108MHz with or without SSC.

A separate control pin can be used to enable or disable the output. The CDCS503 operates in 3.3V environment.

It is characterized for operation from -40°C to 85°C, and available in an 8-pin TSSOP package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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#### **FUNCTION TABLE**

| OE | FS | SSC_SEL 0 | SSC_SEL 1 | SSC AMOUNT | f <sub>OUT</sub> /f <sub>IN</sub> | f <sub>OUT</sub> at f <sub>in</sub> = 27 MHz |
|----|----|-----------|-----------|------------|-----------------------------------|--|
| 0  | х  | x         | х         | x          | x                                 | 3-state                                      |
| 1  | 0  | 0         | 0         | ±0.00%     | 1                                 | 27 MHz                                       |
| 1  | 0  | 0         | 1         | ±0.50%     | 1                                 | 27 MHz                                       |
| 1  | 0  | 1         | 0         | ±1.00%     | 1                                 | 27 MHz                                       |
| 1  | 0  | 1         | 1         | ±2.00%     | 1                                 | 27 MHz                                       |
| 1  | 1  | 0         | 0         | ±0.00%     | 4                                 | 108 MHz                                      |
| 1  | 1  | 0         | 1         | ±0.50%     | 4                                 | 108 MHz                                      |
| 1  | 1  | 1         | 0         | ±1.00%     | 4                                 | 108 MHz                                      |
| 1  | 1  | 1         | 1         | ±2.00%     | 4                                 | 108 MHz                                      |

### **DEVICE INFORMATION**

### **PACKAGE**



### **PIN FUNCTIONS**

| SIGNAL          | PIN  | TYPE   | DESCRIPTION  |  |  |  |
|-----------------|------|--------|--|--|--|--|
| IN              | 1    | I      | LVCMOS Clock input                                   |  |  |  |
| OUT             | 6    | 0      | LVCMOS Clock Output                                  |  |  |  |
| SSC_SEL 0, 1    | 2, 3 | I      | Spread Selection Pins, internal pull-up              |  |  |  |
| OE              | 7    | I      | utput Enable, internal pull-up                       |  |  |  |
| FS              | 5    | I      | Frequency Multiplication Selection, internal pull-up |  |  |  |
| V <sub>DD</sub> | 8    | Power  | 3.3V Power Supply                                    |  |  |  |
| GND             | 4    | Ground | Ground   |  |  |  |

### PACKAGE THERMAL RESISTANCE FOR TSSOP (PW) PACKAGE

over operating free-air temperature range (unless otherwise noted) $^{(1)}$ 

|                 | CDCS503PW 8-PIN TSSOP |     | THER | RMAL AII | RFLOW | (CFM) | UNIT |
|-----------------|-----------------------|-----|------|----------|-------|-------|------|
|                 | CDC3303FW 0-FIN 1330F | 0   | 150  | 250      | 500   | UNII  |      |
| В               | High K                | 149 | 142  | 138      | 132   | °C/W  |      |
| $R_{\theta JA}$ | Low K                 | 230 | 185  | 170      | 150   |       |      |
| D               | High K                | 65  |      |          |       |       | °C/W |
| $R_{\theta JC}$ | Low K                 |     |      |          |       | C/VV  |      |

(1) The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S2P (high-k board).

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### **ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted)

|                  |  | VALUE       | UNIT |
|------------------|--|-------------|------|
| $V_{DD}$         | Supply voltage range                                     | -0.5 to 4.6 | V    |
| V <sub>IN</sub>  | Input voltage range <sup>(1)</sup>                       | -0.5 to 4.6 | V    |
| V <sub>out</sub> | Output voltage range <sup>(1)</sup>                      | -0.5 to 4.6 | V    |
| I <sub>IN</sub>  | Input current (V <sub>I</sub> < 0, V <sub>I</sub> > VDD) | 20          | mA   |
| l <sub>out</sub> | Continuous output current                                | 50          | mA   |
| T <sub>ST</sub>  | Storage temperature range                                | -65 to 150  | °C   |
| T <sub>J</sub>   | Maximum junction temperature                             | 125         | °C   |

<sup>(1)</sup> Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### **RECOMMENDED OPERATING CONDITIONS**

|                                  |                                 |        | MIN                 | NOM                 | MAX                 | UNIT |  |
|----------------------------------|---------------------------------|--------|---------------------|---------------------|---------------------|------|--|
| $V_{DD}$                         | Supply voltage                  |        | 3.0                 |                     | 3.6                 | V    |  |
| f <sub>IN</sub>                  | land the man and                | FS = 0 | 8                   |                     | 32                  | MHz  |  |
|                                  | Input frequency                 | FS = 1 | 8                   |                     | 27                  |      |  |
| V <sub>IL</sub>                  | Low level input voltage LVCMOS  |        |                     |                     | 0.3 V <sub>DD</sub> | V    |  |
| V <sub>IH</sub>                  | High level input voltage LVCMOS |        | 0.7 V <sub>DD</sub> |                     |                     | V    |  |
| VI                               | Input voltage threshold LVCMOS  |        |                     | 0.5 V <sub>DD</sub> |                     | V    |  |
| C <sub>L</sub>                   | Output load test LVCMOS         |        |                     |                     | 15                  | pF   |  |
| I <sub>OH</sub> /I <sub>OL</sub> | Output current                  |        |                     |                     | ±12                 | mA   |  |
| T <sub>A</sub>                   | Operating free-air temperature  |        | -40                 |                     | 85                  | °C   |  |

### **DEVICE CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

|                                | PARAMETER                            | TEST CONDITIONS                                    | MIN | TYP  | MAX | UNIT  |  |
|--------------------------------|--------------------------------------|--|-----|------|-----|-------|--|
| IDD                            | Device supply current                | $f_{out} = 20 \text{ MHz}; FS = 0, \text{ no SSC}$ |     | 19   |     | mA    |  |
| טטו                            | Device supply current                | $f_{out}$ = 70 MHz; FS = 1, SSC = 2%               |     | 22   |     | IIIA  |  |
| 4                              | Output fraguency                     | FS = 0   | 8   |      | 32  | MHz   |  |
| f <sub>OUT</sub>               | Output frequency                     | FS = 1   | 32  |      | 108 | IVIHZ |  |
| I <sub>IH</sub>                | LVCMOS input current                 | $V_I = VDD$ ; $VDD = 3.6 V$                        |     |      | 10  | μΑ    |  |
| I <sub>IL</sub>                | LVCMOS input current                 | $V_1 = 0 \ V; \ VDD = 3.6 \ V$                     |     |      | -10 | μΑ    |  |
|                                |                                      | $I_{OH} = -0.1 \text{mA}$                          | 2.9 |      |     |       |  |
| $V_{OH}$                       | LVCMOS high-level output voltage     | 2.4  |     |      | V   |       |  |
|                                |                                      | I <sub>OH</sub> = - 12mA                           | 2.2 |      |     |       |  |
|                                |                                      | I <sub>OL</sub> = 0.1mA                            |     |      | 0.1 |       |  |
| V <sub>OL</sub>                | LVCMOS low-level output voltage      | I <sub>OL</sub> = 8mA                              |     |      | 0.5 | V     |  |
|                                |                                      | I <sub>OL</sub> = 12mA                             |     |      | 0.8 |       |  |
| I <sub>OZ</sub>                | High- impedance-state output current | OE = Low   | -2  |      | 2   | μΑ    |  |
| t <sub>JIT(C-C)</sub>          | Cycle to cycle jitter <sup>(1)</sup> | f <sub>out</sub> = 108 MHz; FS = 1,                |     | 110  |     | ps    |  |
| 1 /1                           | Rise and fall time <sup>(1)</sup>    | SSC = 1%, 10000 Cycles                             |     | 0.75 |     |       |  |
| t <sub>r</sub> /t <sub>f</sub> | Rise and fall time (*)               | 20%–80%  |     | 0.75 |     | ns    |  |
| O <sub>dc</sub>                | Output duty cycle                    |  | 45% |      | 55% |       |  |
| $f_{MOD}$                      | Modulation frequency                 |  |     | 30   |     | kHz   |  |

<sup>(1)</sup> Measured with Test Load, see Figure 2.

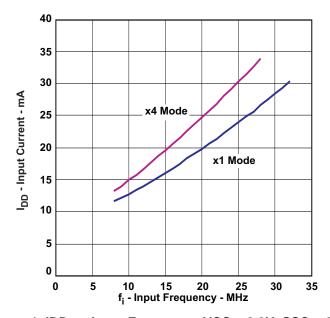


Figure 1. IDD vs Input Frequency, VCC = 3.3V, SSC = 2%, Output Loaded With Test Load



#### **APPLICATION INFORMATION**

### **SSC MODULATION**

The exact implementation of the SSC modulation plays a vital role for the EMI reduction. The CDCS503 uses a triangular modulation scheme implemented in a way that the modulation frequency depends on the VCO frequency of the internal PLL and the spread amount is independent from the VCO frequency.

The modulation frequency can be calculated by using one of the below formulas chosen by frequency multiplication mode.

FS = 0: 
$$f_{mod} = f_{IN} / 708$$
  
FS = 1:  $f_{mod} = f_{IN} / 620$ 

#### PARAMETER MEASUREMENT INFORMATION

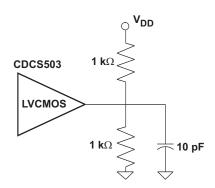


Figure 2. Test Load

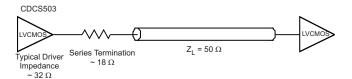


Figure 3. Load for 50-Ω Board Environment

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#### PACKAGING INFORMATION

| Orderable part number | Status | Material type | Package   Pins | Package qty   Carrier | RoHS | Lead finish/<br>Ball material | MSL rating/<br>Peak reflow | Op temp (°C) | Part marking |
|-----------------------|--------|---------------|----------------|-----------------------|------|-------------------------------|----------------------------|--------------|--------------|
|                       | (1)    | (2)           |                |                       | (3)  | (4)                           | (5)                        |              | (6)          |
| CDCS503PW             | Active | Production    | TSSOP (PW)   8 | 150   TUBE            | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 85    | CS503        |
| CDCS503PW.B           | Active | Production    | TSSOP (PW)   8 | 150   TUBE            | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 85    | CS503        |
| CDCS503PWR            | Active | Production    | TSSOP (PW)   8 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 85    | CS503        |
| CDCS503PWR.B          | Active | Production    | TSSOP (PW)   8 | 2000   LARGE T&R      | Yes  | NIPDAU                        | Level-1-260C-UNLIM         | -40 to 85    | CS503        |

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

- (3) RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.
- (4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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#### OTHER QUALIFIED VERSIONS OF CDCS503:

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

## PACKAGE OPTION ADDENDUM

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Automotive : CDCS503-Q1

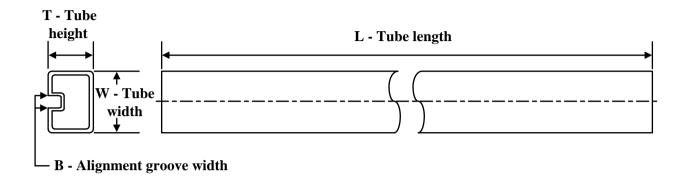
NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## **PACKAGE MATERIALS INFORMATION**

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### **TUBE**

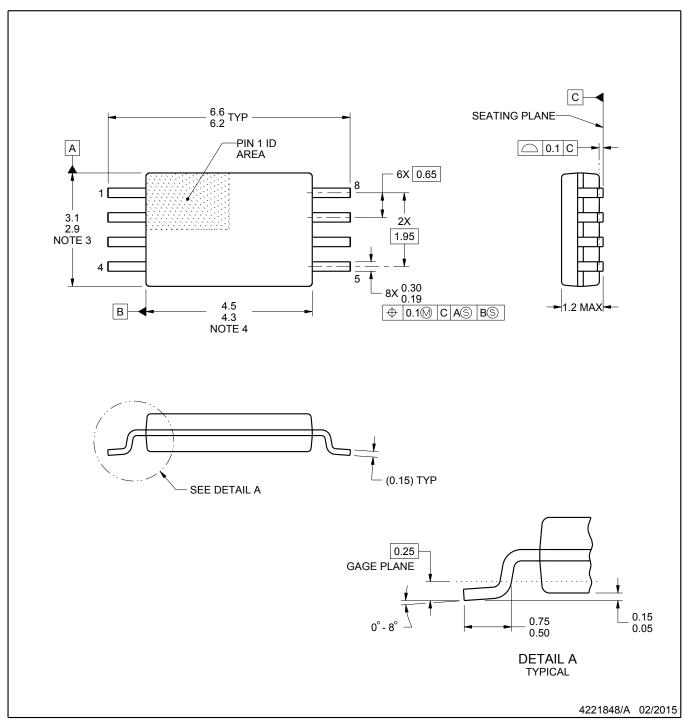


### \*All dimensions are nominal

|   | Device      | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (µm) | B (mm) |
|---|-------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| Ī | CDCS503PW   | PW           | TSSOP        | 8    | 150 | 530    | 10.2   | 3600   | 3.5    |
| Г | CDCS503PW.B | PW           | TSSOP        | 8    | 150 | 530    | 10.2   | 3600   | 3.5    |



SMALL OUTLINE PACKAGE



### NOTES:

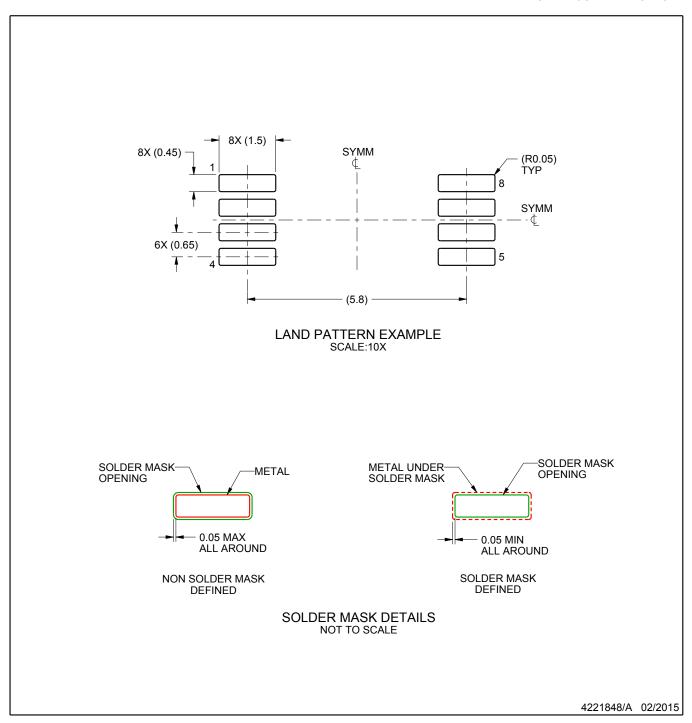
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153, variation AA.



SMALL OUTLINE PACKAGE



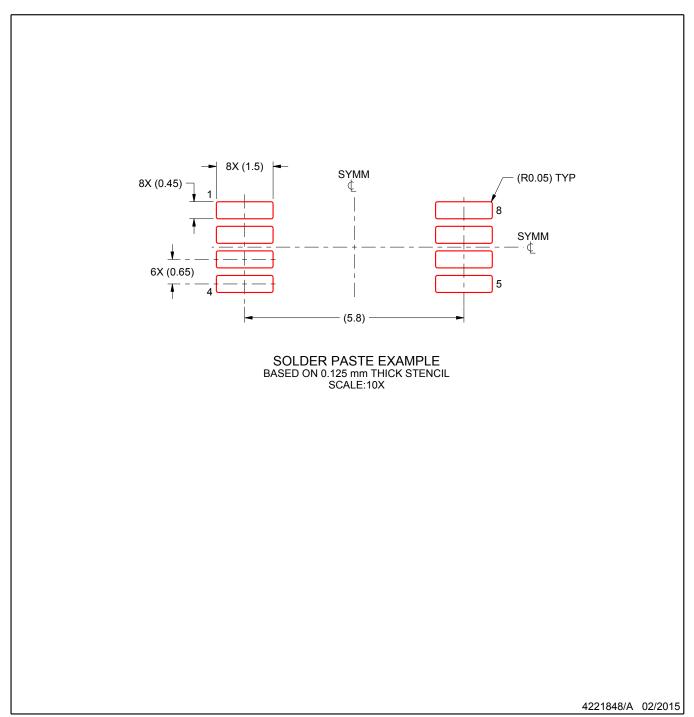
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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